

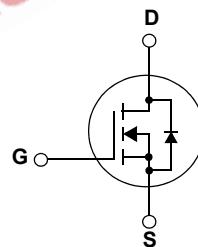
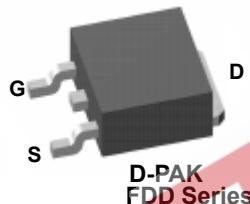
## FDD7N20 / FDU7N20

### N-Channel MOSFET

#### 200V, 5A, 0.69Ω

#### Features

- $R_{DS(on)} = 0.58\Omega$  (Typ.) @  $V_{GS} = 10V$ ,  $I_D = 2.5A$
- Low gate charge (Typ. 5nC)
- Low  $C_{RSS}$  (Typ. 5pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant



#### MOSFET Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted

Symbol	Parameter		Ratings	Units
$V_{DSS}$	Drain to Source Voltage		200	V
$V_{GSS}$	Gate to Source Voltage		$\pm 30$	V
$I_D$	Drain Current	-Continuous ( $T_C = 25^\circ C$ )	5	A
		-Continuous ( $T_C = 100^\circ C$ )	3	
$I_{DM}$	Drain Current	- Pulsed	(Note 1)	A
$E_{AS}$	Single Pulsed Avalanche Energy		62.5	mJ
$I_{AR}$	Avalanche Current	(Note 1)	5	A
$E_{AR}$	Repetitive Avalanche Energy	(Note 1)	4.3	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$	(Note 3)	4.5	V/ns
$P_D$	Power Dissipation	( $T_C = 25^\circ C$ )	43	W
		- Derate above $25^\circ C$	0.34	
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	°C
$T_L$	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C

#### Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.9	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	110	

## Package Marking and Ordering Information $T_C = 25^\circ\text{C}$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD7N20	FDD7N20TM	D-PAK	380mm	16mm	2500
FDD7N20	FDD7N20TF	D-PAK	380mm	16mm	2000
FDU7N20	FDU7N20	I-PAK	-	-	70

## Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
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### Off Characteristics

$\text{BV}_{\text{DSS}}$	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$	200	-	-	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , Referenced to $25^\circ\text{C}$	-	0.2	-	$\text{V}/^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS} = 200\text{V}, V_{GS}=0\text{V}$	-	-	1	$\mu\text{A}$
		$V_{DS} = 160\text{V}, T_C = 125^\circ\text{C}$	-	-	10	$\mu\text{A}$
$I_{\text{GSS}}$	Gate to Body Leakage Current	$V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$	-	-	$\pm 100$	nA

### On Characteristics

$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	3.0	-	5.0	V
$R_{DS(\text{on})}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{V}, I_D = 2.5\text{A}$	-	0.58	0.69	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 40\text{V}, I_D = 2.5\text{A}$ (Note 4)	-	6.2	-	S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}$ $f=1\text{MHz}$	-	185	250	pF
$C_{oss}$	Output Capacitance		-	45	65	pF
$C_{rss}$	Reverse Transfer Capacitance		-	5	10	pF
$Q_g$	Total Gate Charge at 10V		-	5	6.7	nC
$Q_{gs}$	Gate to Source Gate Charge		-	1.7	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge		-	2.4	-	nC

### Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 100\text{V}, I_D = 7\text{A}$ $R_G = 25\Omega$	-	9	28	ns
$t_r$	Turn-On Rise Time		-	30	70	ns
$t_{d(off)}$	Turn-Off Delay Time		-	13	36	ns
$t_f$	Turn-Off Fall Time		-	10	30	ns

### Drain-Source Diode Characteristics

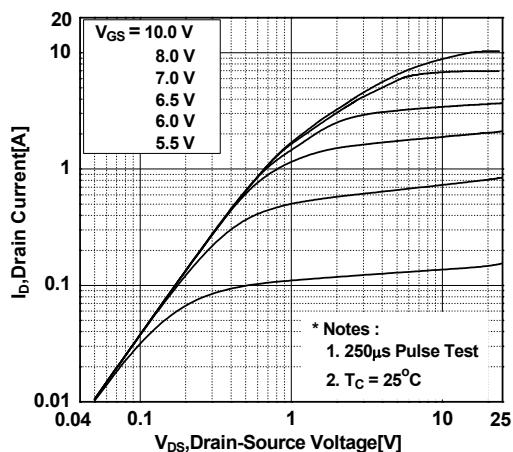
$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	5	A	
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	20	A	
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_{SD} = 5\text{A}$	-	-	$1.4$	V
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0\text{V}, I_{SD} = 7\text{A}$ $dI_F/dt = 100\text{A}/\mu\text{s}$	-	120	-	ns
$Q_{rr}$	Reverse Recovery Charge		(Note 4)	-	0.4	$\mu\text{C}$

#### Notes:

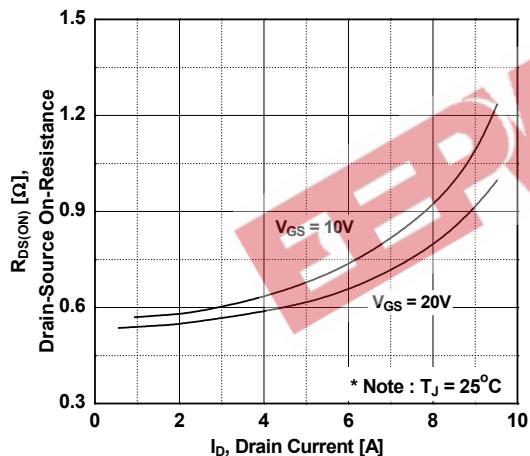
1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $L = 5\text{mH}, I_{AS} = 5\text{A}, V_{DD} = 50\text{V}, R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 5\text{A}, dI/dt \leq 200\text{A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
5. Essentially Independent of Operating Temperature Typical Characteristics

## Typical Performance Characteristics

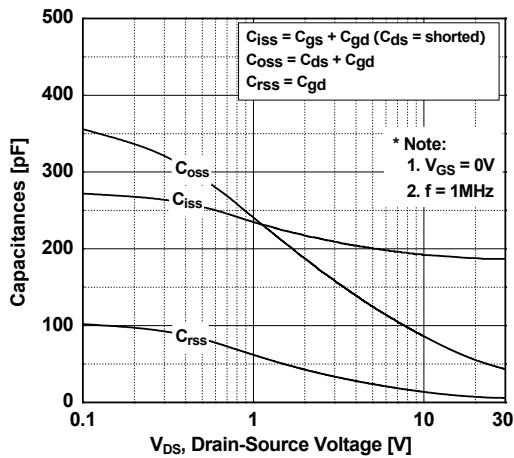
**Figure 1. On-Region Characteristics**



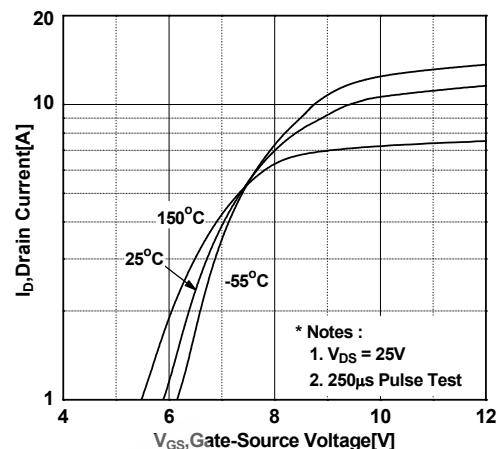
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



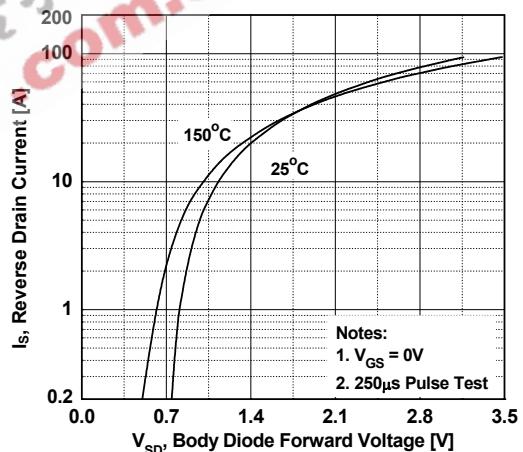
**Figure 5. Capacitance Characteristics**



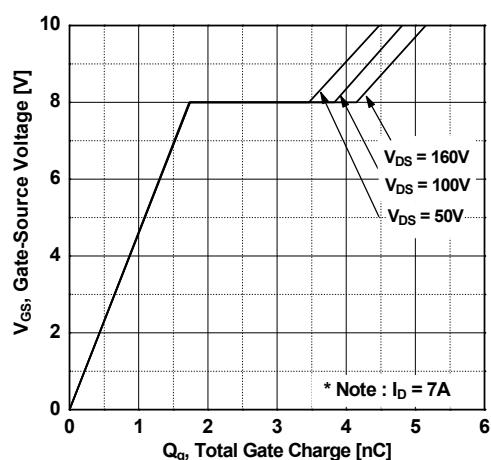
**Figure 2. Transfer Characteristics**



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

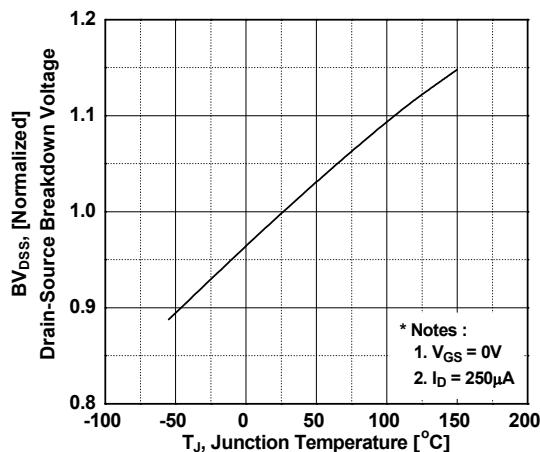


**Figure 6. Gate Charge Characteristics**

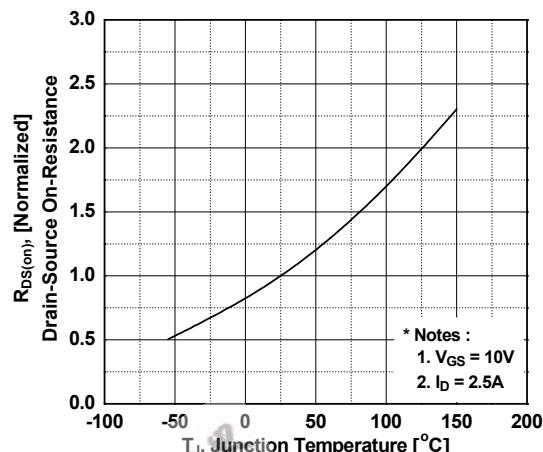


## Typical Performance Characteristics (Continued)

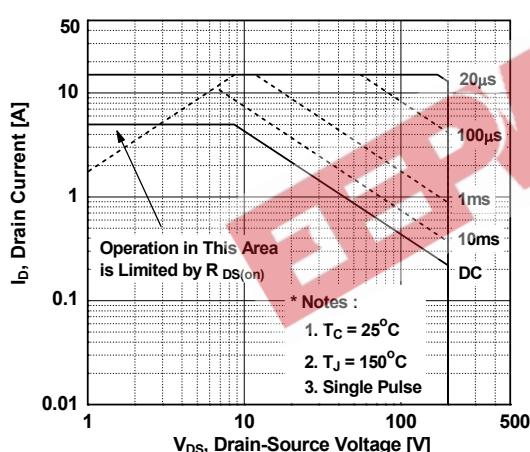
**Figure 7. Breakdown Voltage Variation vs. Temperature**



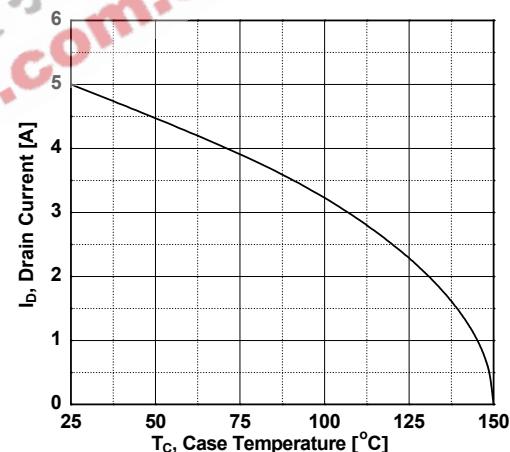
**Figure 8. On-Resistance Variation vs. Temperature**



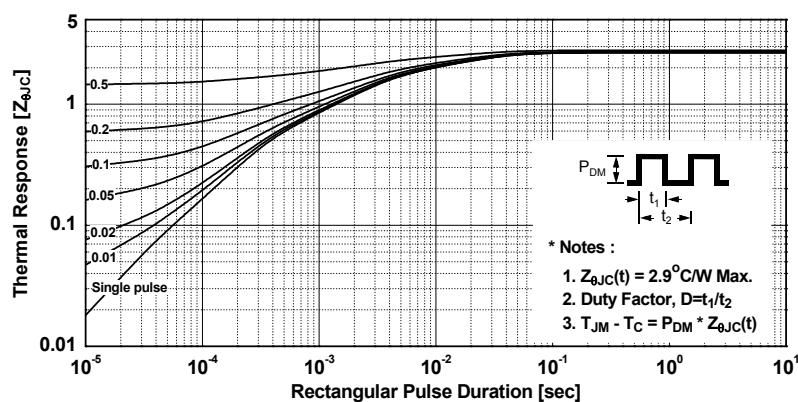
**Figure 9. Maximum Safe Operating Area**



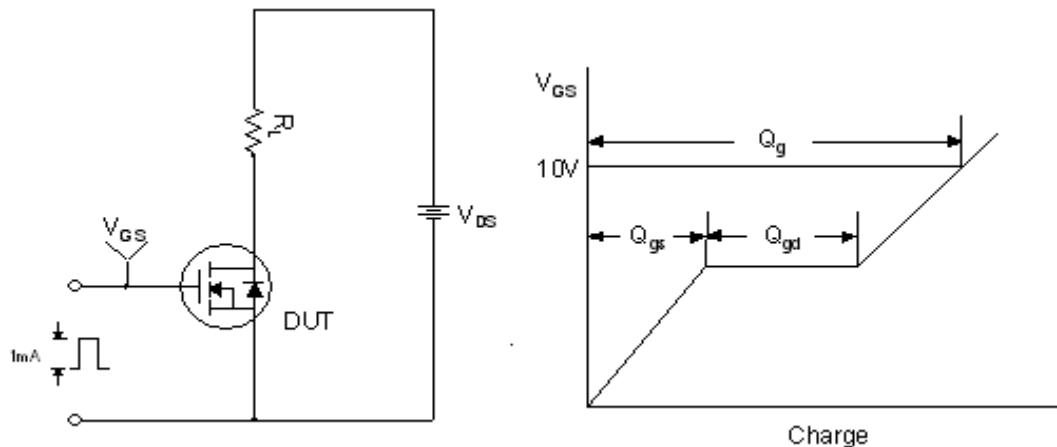
**Figure 10. Maximum Drain Current vs. Case Temperature**



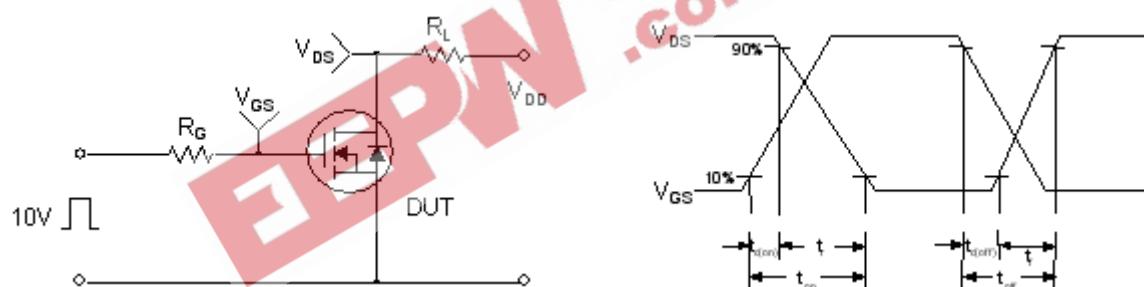
**Figure 11. Transient Thermal Response Curve**



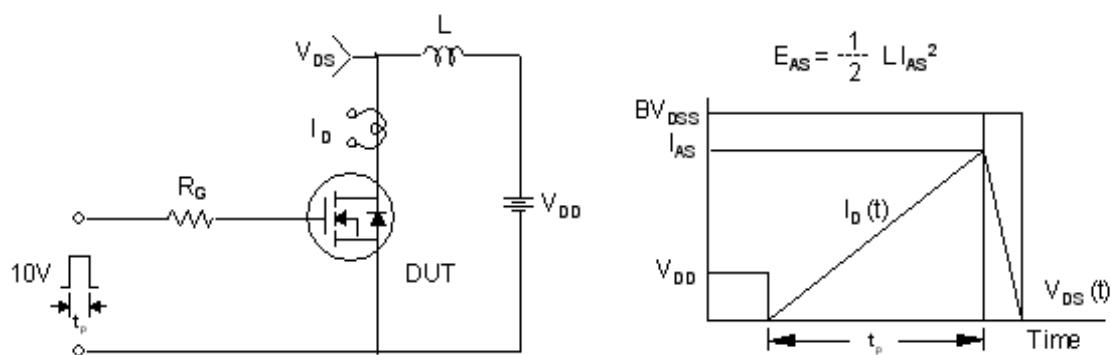
### Gate Charge Test Circuit & Waveform



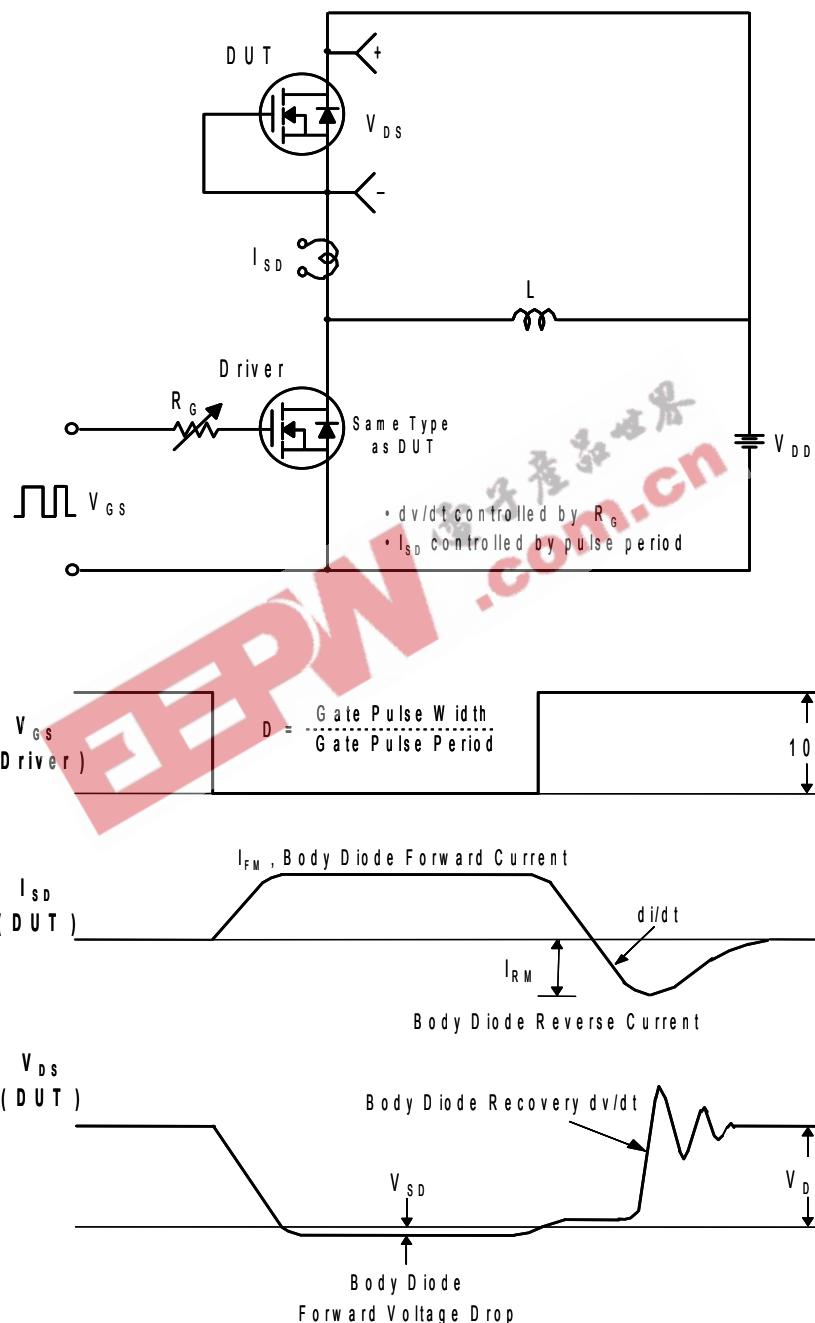
### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms

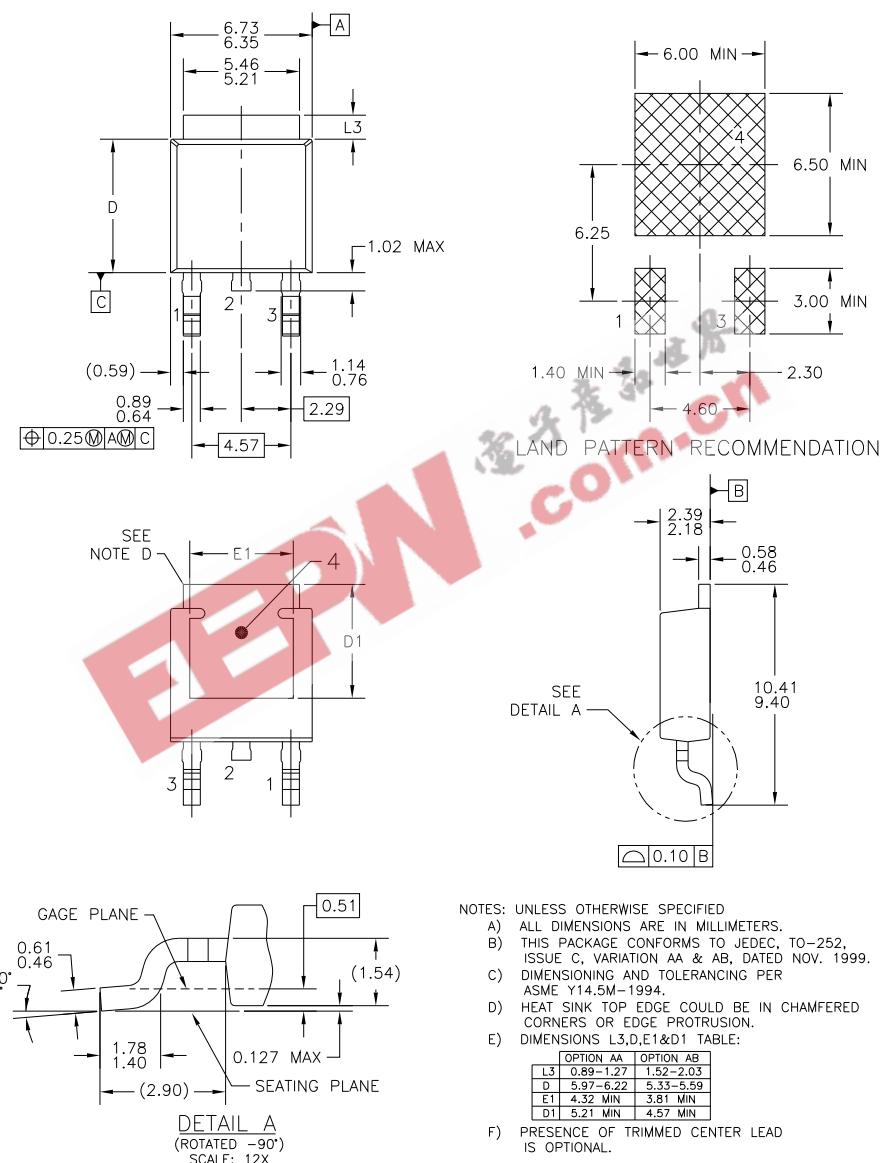


Peak Diode Recovery dv/dt Test Circuit & Waveforms



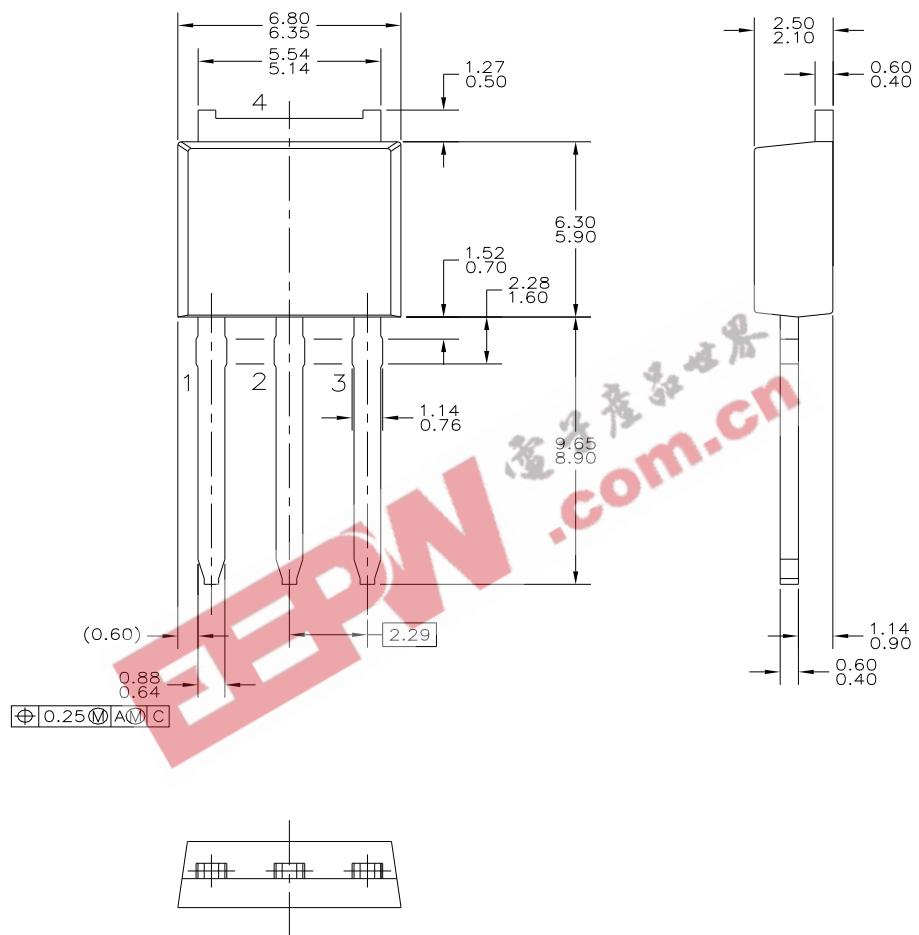
## Mechanical Dimensions

### D-PAK



## Mechanical Dimensions

I-PAK





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